

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit		Page 1 of 4
CHRISTOPHER C. JOHNS		3621		

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Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/681,017	DURBIN ET AL.	
Examiner		Art Unit		Page 2 of 4
CHRISTOPHER C. JOHNS		3621		

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		09/681,017	DURBIN ET AL.	
		Examiner	Art Unit	Page 3 of 4
		CHRISTOPHER C. JOHNS	3621	

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